



## AO7801

### Dual P-Channel Enhancement Mode Field Effect Transistor

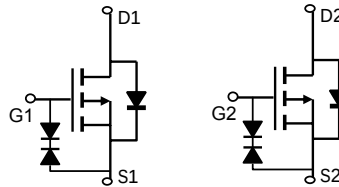
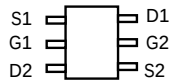
#### General Description

The AO7801 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge, and operation with gate voltages as low as 1.8V, in the small SOT323 footprint. It can be used for a wide variety of applications, including load switching, low current inverters and low current DC-DC converters. It is ESD protected to 2KV HBM. *Standard Product AO7801 is Pb-free (meets ROHS & Sony 259 specifications). AO7801L is a Green Product ordering option. AO7801 and AO7801L are electrically identical.*

#### Features

$V_{DS}$  (V) = -20V  
 $I_D$  = -0.6A ( $V_{GS}$  = -4.5V)  
 $R_{DS(ON)} < 520m\Omega$  ( $V_{GS}$  = -4.5V)  
 $R_{DS(ON)} < 700m\Omega$  ( $V_{GS}$  = -2.5V)  
 $R_{DS(ON)} < 950m\Omega$  ( $V_{GS}$  = -1.8V)

**SC-70-6  
(SOT-323)  
Top View**



#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                              | Symbol                 | Maximum    | Units            |
|----------------------------------------|------------------------|------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$               | -20        | V                |
| Gate-Source Voltage                    | $V_{GS}$               | $\pm 8$    | V                |
| Continuous Drain Current <sup>A</sup>  | $I_D$                  | -0.6       | A                |
| $T_A=25^\circ\text{C}$                 |                        |            |                  |
| Current <sup>A</sup>                   | $T_A=70^\circ\text{C}$ | -0.48      |                  |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$               | -3         |                  |
| Power Dissipation <sup>A</sup>         | $P_D$                  | 0.3        | W                |
|                                        |                        | 0.19       |                  |
| $T_A=25^\circ\text{C}$                 |                        |            |                  |
| $T_A=70^\circ\text{C}$                 |                        |            |                  |
| Junction and Storage Temperature Range | $T_J, T_{STG}$         | -55 to 150 | $^\circ\text{C}$ |

#### Thermal Characteristics

| Parameter                                |              | Symbol          | Typ | Max | Units              |
|------------------------------------------|--------------|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $t \leq 10s$ | $R_{\theta JA}$ | 360 | 415 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> | Steady-State |                 | 400 | 460 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Lead <sup>C</sup>    | Steady-State | $R_{\theta JL}$ | 300 | 350 | $^\circ\text{C/W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                                    | Min  | Typ        | Max        | Units |
|-----------------------------|---------------------------------------|-----------------------------------------------------------------------------------------------|------|------------|------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                               |      |            |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V                                                   | -20  |            |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                            |      |            | -1<br>-5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±8V                                                     |      |            | ±10        | μA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =-250μA                                       | -0.5 | -0.6       | -0.9       | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-5V                                                  | -3   |            |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-0.6A<br>T <sub>J</sub> =125°C                        |      | 400<br>542 | 520<br>700 | mΩ    |
|                             |                                       | V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-0.5A                                                 |      | 540        | 700        | mΩ    |
|                             |                                       | V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-0.4A                                                 |      | 700        | 950        | mΩ    |
|                             |                                       |                                                                                               |      |            |            |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-0.6A                                                   |      | 1.7        |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-0.5A, V <sub>GS</sub> =0V                                                    |      | -0.86      | -1         | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                               |      |            | -0.4       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                               |      |            |            |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =-10V, f=1MHz                                            |      | 114        | 140        | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                               |      | 17         |            | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                               |      | 14         |            | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                              |      | 12         | 17         | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                               |      |            |            |       |
| Q <sub>g</sub>              | Total Gate Charge                     | V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-10V, I <sub>D</sub> =-0.6A                          |      | 1.44       | 1.8        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                               |      | 0.14       |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                               |      | 0.35       |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-10V, R <sub>L</sub> =16.7Ω,<br>R <sub>GEN</sub> =3Ω |      | 6.5        |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                               |      | 6.5        |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                               |      | 18.2       |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                               |      | 5.5        |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-0.6A, dI/dt=100A/μs                                                          |      | 10         | 13         | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-0.6A, dI/dt=100A/μs                                                          |      | 3          |            | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any a given application depends on the user's specific board design. The current rating is based on the ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

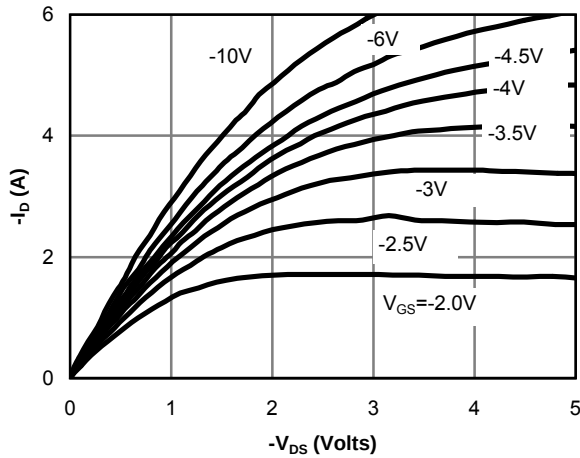


Fig 1: On-Region Characteristics

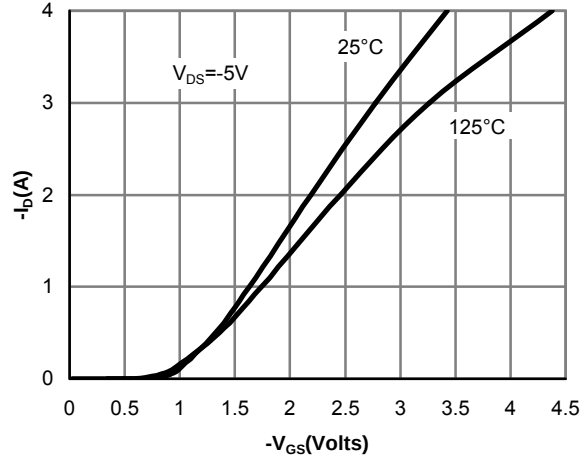


Figure 2: Transfer Characteristics

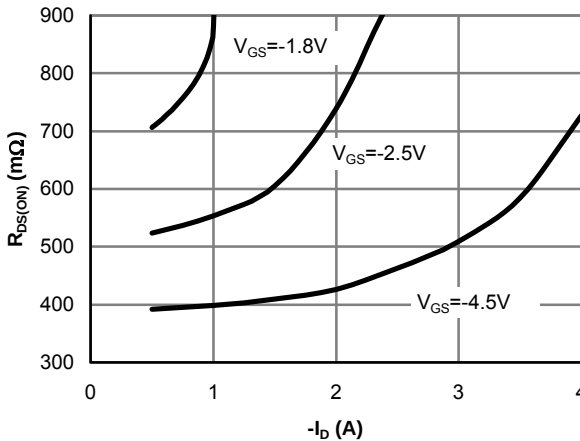


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

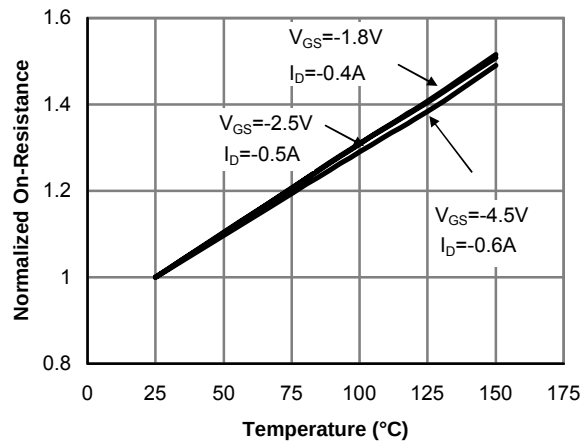


Figure 4: On-Resistance vs. Junction Temperature

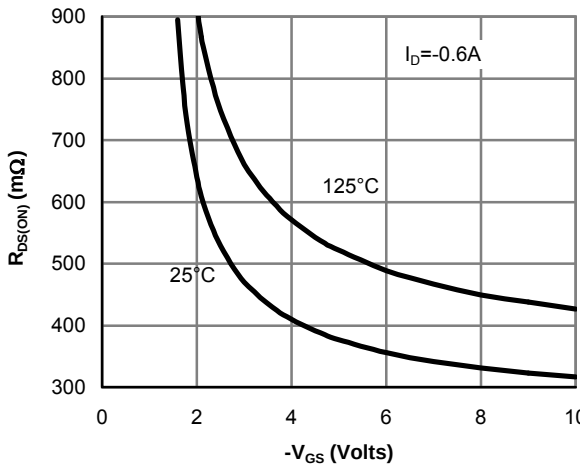


Figure 5: On-Resistance vs. Gate-Source Voltage

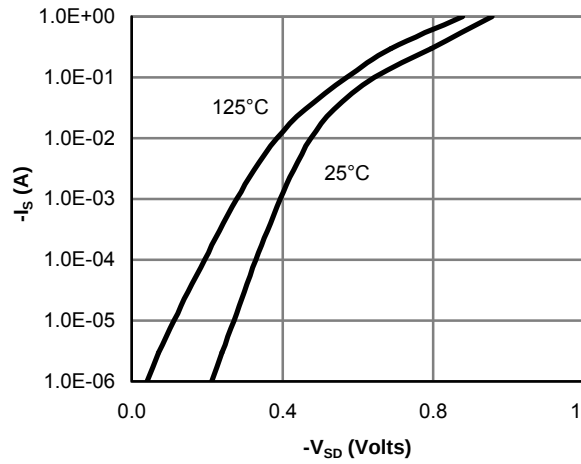


Figure 6: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

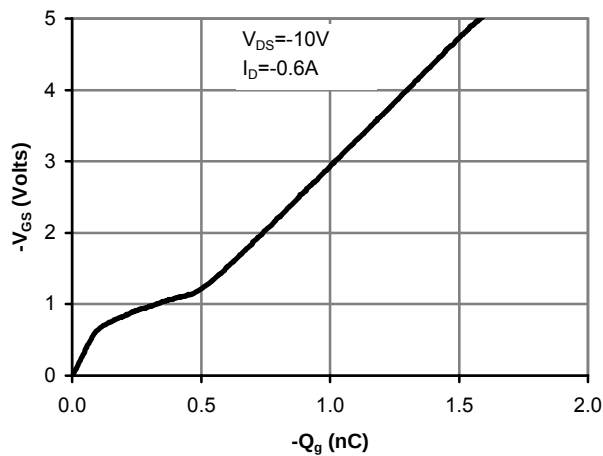


Figure 7: Gate-Charge Characteristics

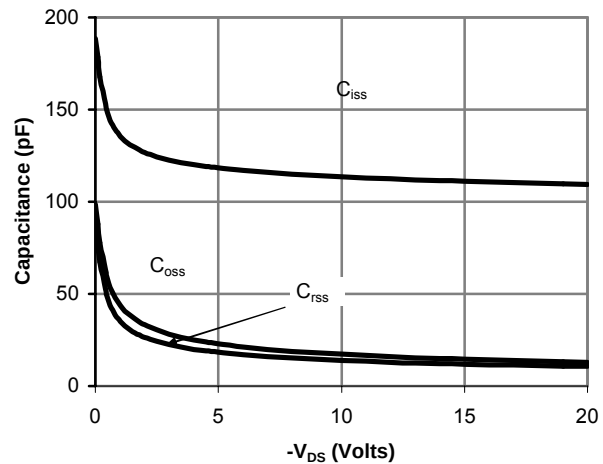


Figure 8: Capacitance Characteristics

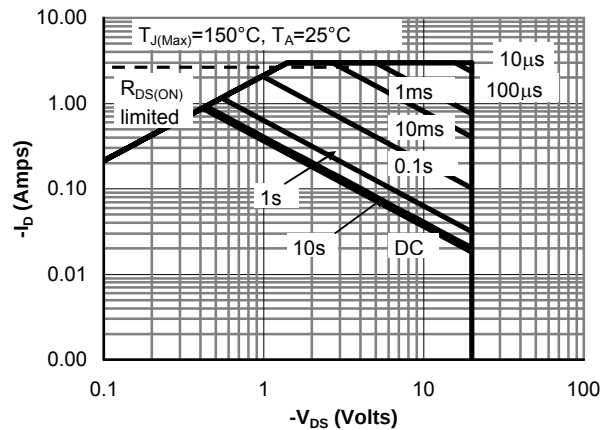


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

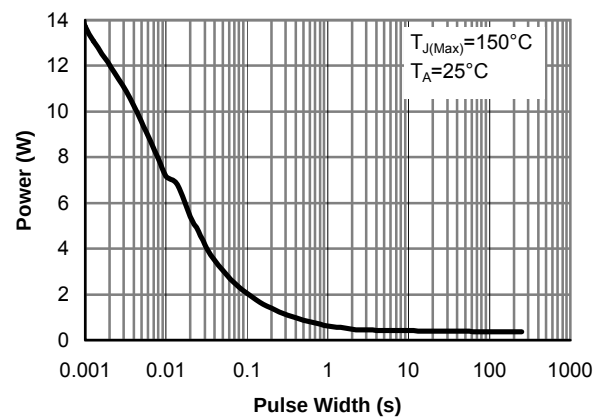


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

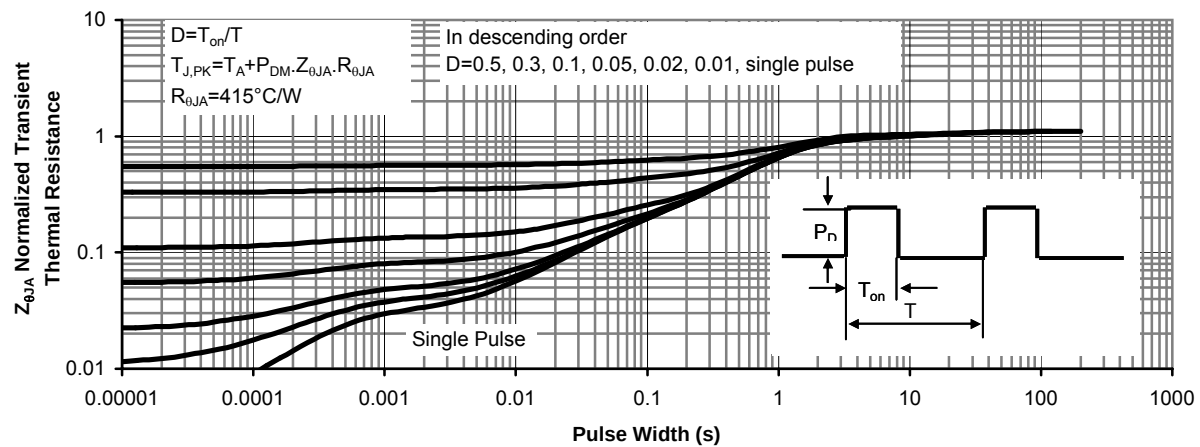


Figure 11: Normalized Maximum Transient Thermal Impedance